60V, N-CHANNEL

International **100** Rectifier

POWER MOSFET THRU-HOLE (TO-257AA)

Product Summary

| Part Number | RDS(on) | ID | Eyelets |
|-------------|---------|------|---------|
| IRFY044C | 0.040 Ω | 16*A | Ceramic |
| IRFY044CM | 0.040 Ω | 16*A | Ceramic |

HEXFET® MOSFET technology is the key to International Rectifier's advanced line of power MOSFET transistors. The efficient geometry design achieves very low on-state resistance combined with high transconductance. HEXFET transistors also feature all of the well-established advantages of MOSFETs, such as voltage control, very fast switching, ease of paralleling and electrical parameter temperature stability. They are well-suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers, high energy pulse circuits, and virtually any application where high reliability is required. The HEXFET transistor's totally isolated package eliminates the need for additional isolating material between the device and the heatsink. This improves thermal efficiency and reduces drain capacitance.

Absolute Maximum Ratings



Features:

Simple Drive Requirements

IRFY044C, IRFY044CM

HEXFET[®] MOSFET TECHNOLOGY

- Ease of Paralleling
- Hermetically Sealed
- Electrically Isolated
- Ceramic Eyelets
- Ideally Suited For Space Level Applications

| | Parameter | | Units |
|--|---------------------------------|--|-------|
| ID @ VGS = 10V, TC = 25°C | Continuous Drain Current | 16* | |
| ID @ VGS = 10V, TC = 100°C | Continuous Drain Current | 16* | A |
| IDM | Pulsed Drain Current ① | 156 | |
| P _D @ T _C = 25°C | Max. Power Dissipation | 100 | W |
| | Linear Derating Factor | 0.8 | W/°C |
| VGS | Gate-to-Source Voltage | ±20 | V |
| EAS | Single Pulse Avalanche Energy 2 | 100 | mJ |
| IAR | Avalanche Current ① | 16* | А |
| EAR | Repetitive Avalanche Energy ① | 10 | mJ |
| dv/dt | Peak Diode Recovery dv/dt 3 | 4.5 | V/ns |
| TJ | Operating Junction | -55 to 150 | |
| TSTG | Storage Temperature Range | | °C |
| | Lead Temperature | 300(0.063in./1.6mm from case for 10 sec) | |
| | Weight | 4.3 (Typical) | g |

* Current is limited by pin diameter For footnotes refer to the last page

| | Parameter | Min | Тур | Max | Units | Test Conditions |
|--------------------------------|---|-----|------|------|-------|---|
| BVDSS | Drain-to-Source Breakdown Voltage | 60 | | — | V | $V_{GS} = 0V, I_{D} = 1.0mA$ |
| $\Delta BV_{DSS}/\Delta T_{J}$ | Temperature Coefficient of Breakdown Voltage | _ | 0.68 | _ | V/°C | Reference to 25°C, ID = 1.0mA |
| RDS(on) | Static Drain-to-Source On-State Resistance | _ | _ | 0.04 | Ω | VGS = 10V, ID = 16A ④ |
| VGS(th) | Gate Threshold Voltage | 2.0 | — | 4.0 | V | $V_{DS} = V_{GS}$, $I_D = 250 \mu A$ |
| 9fs | Forward Transconductance | 17 | — | — | S (ひ) | V _{DS} > 15V, I _{DS} = 16A ④ |
| IDSS | Zero Gate Voltage Drain Current | — | — | 25 | μA | V _{DS} = 48V ,V _{GS} =0V |
| | | — | — | 250 | μΑ | V _{DS} = 48V, |
| | | | | | | $V_{GS} = 0V, T_{J} = 125^{\circ}C$ |
| IGSS | Gate-to-Source Leakage Forward | — | — | 100 | nA | $V_{GS} = 20V$ |
| IGSS | Gate-to-Source Leakage Reverse | _ | — | -100 | | V _{GS} = -20V |
| Qg | Total Gate Charge | _ | | 88 | | VGS =10V, ID = 16A |
| Qgs | Gate-to-Source Charge | — | — | 15 | nC | $V_{DS} = 30V$ |
| Qgd | Gate-to-Drain ('Miller') Charge | _ | | 52 | 1 | |
| ^t d(on) | Turn-On Delay Time | _ | — | 23 | | $V_{DD} = 30V, I_D = 16A,$ |
| tr | Rise Time | _ | _ | 130 | | R _G = 9.1Ω |
| ^t d(off) | Turn-Off Delay Time | _ | — | 81 | ns | |
| tf | FallTime | _ | — | 79 | | |
| L _S +L _D | Total Inductance | _ | 6.8 | | nH | Measured from drain lead (6mm/0.25in. from package) to source lead (6mm/0.25in. from package) |
| C _{iss} | Input Capacitance | _ | 2400 | _ | | $V_{GS} = 0V, V_{DS} = 25V$ |
| C _{oss} | Output Capacitance | | 1100 | — | pF | f = 1.0MHz |
| C _{rss} | Reverse Transfer Capacitance | _ | 230 | | | |

Source-Drain Diode Ratings and Characteristics

| | Parameter | Min | Тур | Max | Units | Test Conditions |
|-----|--|--|-----|-----|-------|---|
| IS | Continuous Source Current (Body Diode) | | _ | 16* | А | |
| ISM | Pulse Source Current (Body Diode) ① | _ | — | 156 | ~ | |
| VSD | Diode Forward Voltage | | — | 2.5 | V | $T_j = 25^{\circ}C, I_S = 16A, V_{GS} = 0V @$ |
| trr | Reverse Recovery Time | | — | 220 | nS | Tj = 25°C, IF = 16A, di/dt ≤ 100A/μs |
| QRR | Reverse Recovery Charge | — | — | 1.6 | μC | $V_{DD} \leq 50V @$ |
| ton | Forward Turn-On Time Intrinsic turn-on | Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by $L_{S} + L_{D}$. | | | | |

* Current is limited by pin diameter

Thermal Resistance

| | Parameter | Min | Тур | Мах | Units | Test Conditions |
|--------------------|---------------------|-----|------|------|-------|----------------------|
| RthJC | Junction-to-Case | _ | _ | 1.25 | | |
| RthCS | Case-to-sink | — | 0.21 | _ | °C/W | |
| R _{th} JA | Junction-to-Ambient | — | — | 80 | | Typical socket mount |

Note: Corresponding Spice and Saber models are available on the G&S Website.

For footnotes refer to the last page

International

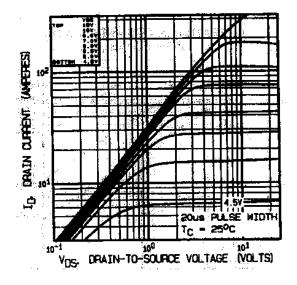


Fig 1. Typical Output Characteristics

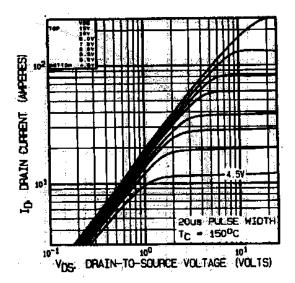


Fig 2. Typical Output Characteristics

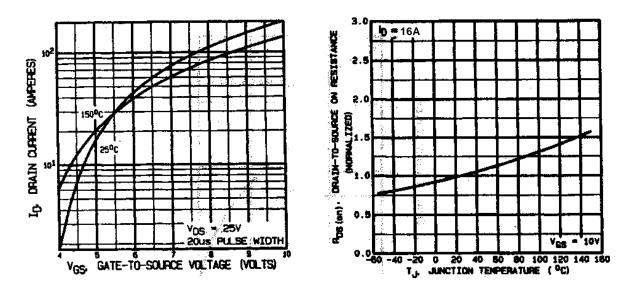
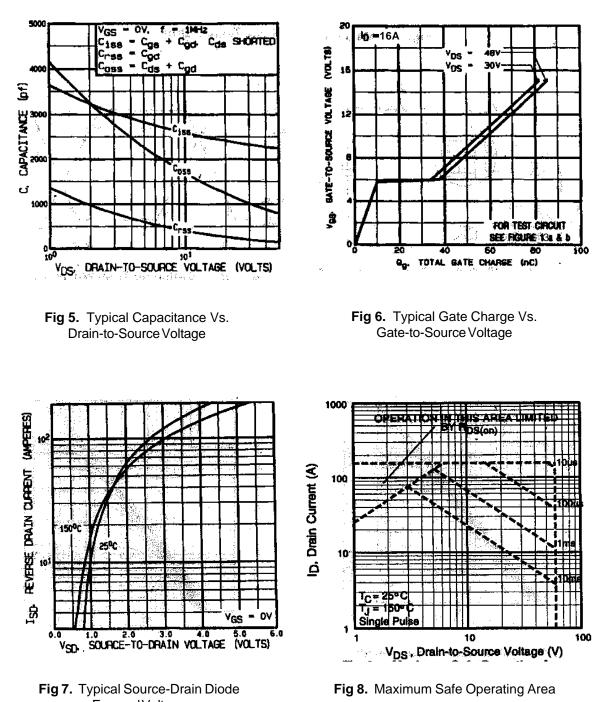
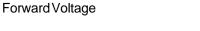


Fig 3. Typical Transfer Characteristics

Fig 4. Normalized On-Resistance Vs. Temperature

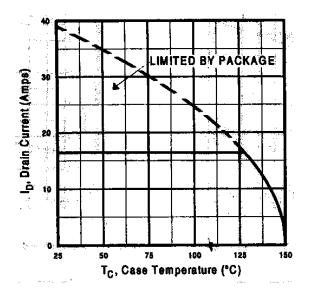
IRFY044C, IRFY044CM

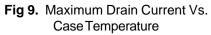


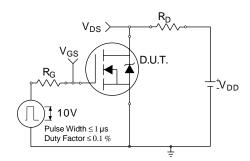


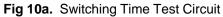
IRFY044C, IRFY044CM

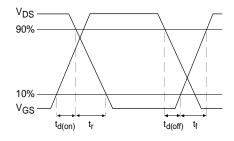
International

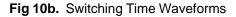












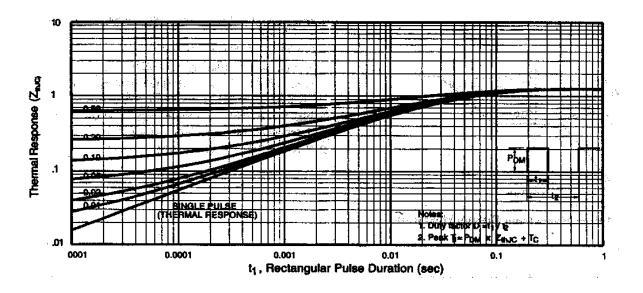


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

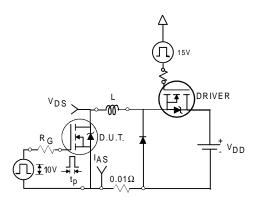


Fig 12a. Unclamped Inductive Test Circuit

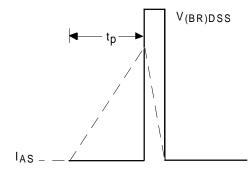


Fig 12b. Unclamped Inductive Waveforms

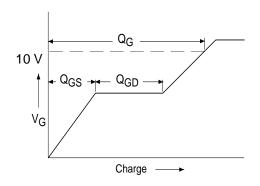


Fig 13a. Basic Gate Charge Waveform

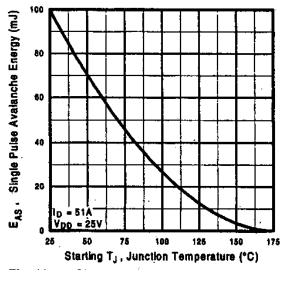


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

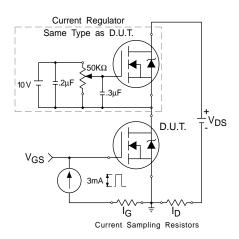


Fig 13b. Gate Charge Test Circuit

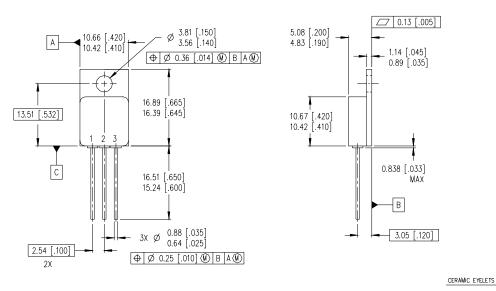
International

IRFY044C, IRFY044CM

Foot Notes:

- ① Repetitive Rating; Pulse width limited by maximum junction temperature.
- \odot VDD = 25V, starting TJ = 25°C, L= 0.78mH Peak IL = 16A, VGS = 10V
- $\$ ISD \leq 16A, di/dt \leq 100A/ μ s,
 - $V_{DD} \le 60V, T_{J} \le 150^{\circ}C$
- $\textcircled{ \ }$ 9 Pulse width \leq 300 $\mu s;$ Duty Cycle \leq 2%

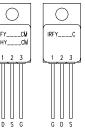
Case Outline and Dimensions — TO-257AA



NOTES:

- 1. DIMENSIONING & TOLERANCING PER ANSI Y14.5M-1994.
- 2. CONTROLLING DIMENSION: INCH.
- 3. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 4. OUTLINE CONFORMS TO JEDEC OUTLINE TO-257AA.

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|--|--|------------|----------|
| | | IRF IRH | Y_ Y_ |
| | | <u>_</u> | F |
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| | | | |



International

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LEGEND

D - DRAIN

G - GATE

S - SOURCE

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